Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination LEE, KEVIN J.	
10/808,763		
Examiner	Art Unit	
Lois Zheng	1742	

SEARCHED				
Class	Subclass	Date	Examiner	
204	224M	1/5/2007	LLZ	
204	224R	1/5/2007	LLZ	
204	228.1	1/5/2007	LLZ	
204	229.1	1/5/2007	LLZ	
204	229.4	1/5/2007	LLZ	
204	229.8	1/5/2007	LLZ	
204	230.1	1/5/2007	LLZ	
204	230.2	1/5/2007	LLZ	
205	641-644	1/5/2007	LLZ	
205	666-667	1/5/2007	LLZ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	DATE	EXMR
Inventorship search	1/5/2007	7 LLZ
EAST search	1/5/2007	7 LLZ
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